

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
		Examiner Satish S. Rampuria	Art Unit 2191	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0225971 A1	12-2003	Oishi et al.	711/115
*	B	US-2003/0046447 A1	03-2003	Kouperchliak et al.	709/321
*	C	US-2002/0145632 A1	10-2002	Shmueli et al.	345/835
*	D	US-6,282,710 B1	08-2001	Boehler, Paul Joseph	717/174
*	E	US-2006/0173980 A1	08-2006	Kobayashi et al.	709/222
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Wiener et al., Meeting USB and IEEE1394 overcurrent protection requirements using PolySwitch devices, IEEE, Nov 1997 Page(s): 442-475
	V	Remple, USB on-the-go interface for portable devices, IEEE, June 2003 Page(s): 8- 9
	W	Jankovec et al., Analog circuit development system, IEEE, Sept. 2003 Page(s): 125- 129 vol.1
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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